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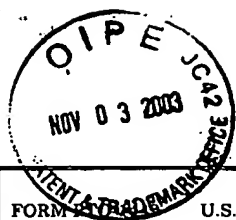
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

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11/24/04

(09/99)



FORM 1-2 U.S. Department of Commerce Patent & Trademark Office INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>	Attorney Docket No. 218TG/48722	Serial No. 09/524,755
	Applicant: Peter HEINRICH et al.	
	Filing Date March 13, 2000	Group

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Sub-Class	TRANSLATION	
							Yes	No
	AK							
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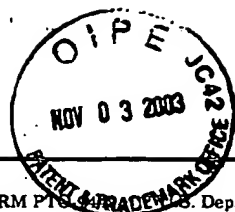
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

SCC	AQ	VII Finnish Conference on Physics in Industry, Nov. 1-2, 1995, Tampere, Finland entitled "Real-Time Optical Spray Pattern Diagnostics for Thermal Spraying" by T. Lehtinen et al.
SCC	AR	Proceedings of the XXX Annual Conference of the Finnish Physical Society entitled "In-Flight Particle Visualisation in Thermal Plasma Spraying Using an Intensified CCD Camera" by T. Lehtinen et al.
SCC	AS	Proceedings of the XXXI Annual Conference of the Finnish Physical Societ, March 13-15, 1997, Helsinki, Finland entitled "In-Flight Particle Concentration Measurements in Thermal Plasma Spraying Using a CCD Camera by T. Lehtinen et.al.

EXAMINER *Sheela Chohan*DATE CONSIDERED *4/8/04*

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FORM PTO-101 U.S. Department of Commerce Patent & Trademark Office	Attorney Docket No. 218TG/48722	Serial No. 09/524,755
	Applicant: Peter HEINRICH et al.	
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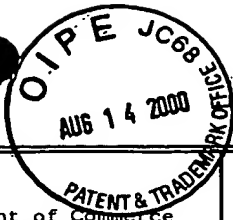
INFORMATION DISCLOSURE STATEMENT
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U.S. PATENT DOCUMENTS							
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							Yes	No
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	AM							
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	AO							
	AP							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
See	AQ	Optics Day '97 - Proceedings Finnish Optical Society Tampere University of Technology, Feb. 21, 2007, Tampere, Finland entitled "Optical Spray Pattern Diagnostics for Thermal Spraying by T. Lehtinen et al.					
	AR						
	AS						

EXAMINER <i>Shieh Chuan</i>	DATE CONSIDERED <i>4/7/04</i>
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Form PTO-1449

U.S. Department of Commerce
Patent & Trademark OfficeAtty. Docket No.
218TG/48722Serial No.
09/524,755Applicant:
Peter Heinrich et al.Filing Date:
March 13, 2000

Group

INFORMATION DISCLOSURE STATEMENT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
SCE	AA	5,047,612	1991	Savkar et al.	29	12147	—
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FOREIGN PATENT DOCUMENTS

		Document	Date	Country	Class	Sub-class	Translation Yes No
SCE	AK	EP08269672	1996	Europe	—	—	Abstract
↓	AL	EP0955384A1	1999	Europe	—	—	Abstract
↓	AM	DE3515209A1	1985	Germany	—	—	Abstract
SCE	AN	DE19820195A1	1999	Germany	—	—	Abstract
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

SCE	AQ	Klaus Voss and Herbert Suesse, "Invariant Fitting of Planar Objects by Primitives", 1997, pgs. 80-84.
	AR	
	AS	

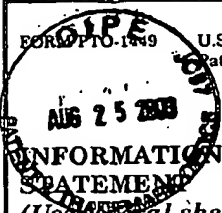
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1/24/03

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 <p>U.S. Department of Commerce Patent & Trademark Office</p> <p>INFORMATION DISCLOSURE STATEMENT</p> <p>(Use several sheets if necessary)</p>	Attorney Docket No. 218TG.48722	Serial No. 09/524,755
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	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

SCC	AQ	T. LEHTINEN, et al., "Correlations Between In-Flight Particle Concentrations and Coating Properties in Atmospheric Plasma Spraying of Alumina" pages 525-530							
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	AS								

EXAMINER *Sheel Uason*DATE CONSIDERED *1/24/04*

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